

Report No. : EED32I002128 Page 1 of 22

FCC TEST REPORT

Product : Door Bell

Trade mark : Kenxen

Model/Type reference : DB100C, DB100W

Serial Number : N/A

Report Number : EED32I002128
FCC ID : 2AEBDDB100C
Date of Issue : Aug. 31, 2016

Test Standards : 47 CFR Part 15 Subpart B (2015)

Test result : PASS

Prepared for:

Kenxen Electronic (SZ) Limited
Building A13, Zone D. Minzhu western Industrial Area. Shajing Town.
Baoan District. Shenzhen, Guangdong Province. China.

Prepared by:

Centre Testing International Group Co., Ltd. Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong, China

TEL: +86-755-3368 3668 FAX: +86-755-3368 3385

Approved by Report Seal

ean Yang Re

Reviewed by:

Date:

Aug. 31, 2016

Sheek Luo

Lab supervisor

Check No.: 2384342123









2 Version



Page	2	of	22
------	---	----	----

Version No. Date		Version No. Date Description		Description	tion	
00	Aug. 31, 2016	Original				
		(67)				

















































































Report No.: EED32I002128 Page 3 of 22

3 Test Summary

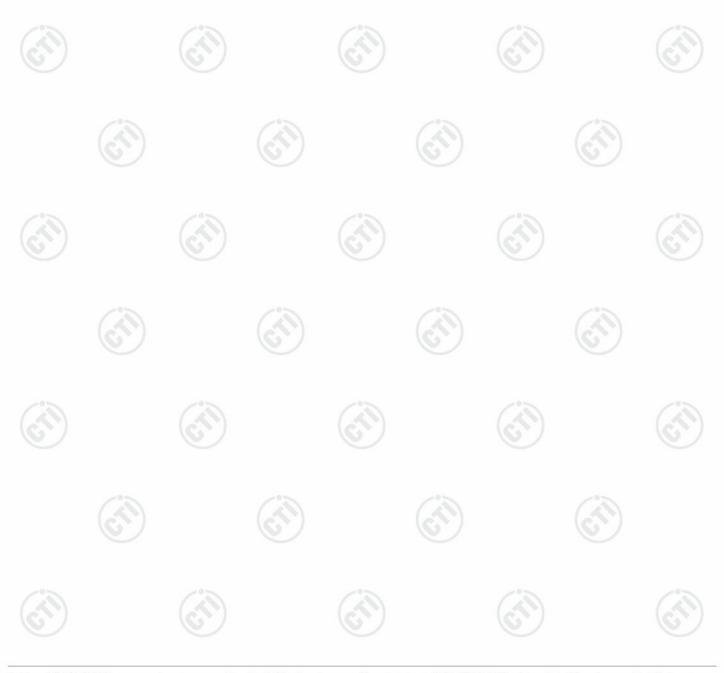
Test Item	Test Requirement	Test method	Result	
Radiated Emission	47 CFR Part 15B	ANSI C63.4-2014	PASS	
Conducted Emission (150KHz to 30MHz)	47 CFR Part 15B	ANSI C63.4-2014	N/A*	

Remark:

The tested sample and the sample information are provided by the client.

Model No.: DB100C, DB100W

Only the model DB100C was tested, electrical circuit design, layout, components used and internal wiring were identical for the above models, Only different is model name.



^{*} The device is battery operated and not connected to AC mains, so the conducted emission is not applicable.









Page 4 of 22

Contents

			Page
1 COVER PAGE			1
2 VERSION			2
3 TEST SUMMARY			3
4 CONTENTS			4
5 GENERAL INFORMATION			5
5.1 CLIENT INFORMATION			5
5.2 GENERAL DESCRIPTION OF	EUT		5
	SUBJECTIVE TO THIS STANDARD		
	MODE		
	Units		
5.8 DEVIATION FROM STANDAR	DS		
5.9 ABNORMALITIES FROM STA	NDARD CONDITIONS		
	QUESTED BY THE CUSTOMER INTY (95% CONFIDENCE LEVELS, I		
		,	
6 EQUIPMENT LIST			
7 TEST RESULTS AND MEAS			
7.1 RADIATED EMISSION			g
APPENDIX 1 PHOTOGRAPHS	OF TEST SETUP	•••••	14
APPENDIX 2 PHOTOGRAPHS	OF EUT		15









































5 General Information

5.1 Client Information

Applicant:	Kenxen Electronic (SZ) Limited
Address of Applicant:	Building A13, Zone D. Minzhu western Industrial Area. Shajing Town. Baoan District. Shenzhen, Guangdong Province. China.
Manufacturer:	Kenxen Electronic (SZ) Limited
Address of Manufacturer:	Building A13, Zone D. Minzhu western Industrial Area. Shajing Town. Baoan District. Shenzhen, Guangdong Province. China.
Factory:	Kenxen Electronic (SZ) Limited
Address of Factory:	Building A13, Zone D. Minzhu western Industrial Area. Shajing Town. Baoan District. Shenzhen, Guangdong Province. China.

5.2 General Description of EUT

Product Name:	Door Bell	
Model No.:	DB100C, DB100W	(8,5)
Test Model No.:	DB100C	
Trade Mark:	Kenxen	
Power Supply:	DC 3.0V (Two 1.5V AA batteries)	/ * /

5.3 Product Specification subjective to this standard

Frequency Range:	433MHz
EUT Function:	The Door Bell receiving 433MHz control signal from the corresponding transmitter to generate the music to alert the user someone is visiting
Test voltage:	DC 3V
Sample Received Date:	Jul. 26, 2016
Sample tested Date:	Jul. 26, 2016 to Aug. 10, 2016

5.4 Test Environment and Mode

Operating Environment:				
Temperature:	25°C			
Humidity:	48%			
Atmospheric Pressure:	1010mbar			/
Test mode:		(6,52)	(6,7)	(c)
Normal Operation mode:	Receive contr	ol signal and pla	ay music.	6

5.5 Description of Support Units

The EUT has been tested with associated equipment below.

Asso	ciated equipment name	Manufacture	Model	Supplied by
AE1	controller	Quhwa	QH-860A	Client





Report No. : EED32I002128 Page 6 of 22

5.6 Test Location

All tests were performed at:

Centre Testing International Group Co., Ltd.

Hongwei Industrial Zone, Bao'an 70 District, Shenzhen, Guangdong, China 518101

Telephone: +86 (0) 755 3368 3668 Fax:+86 (0) 755 3368 3385

No tests were sub-contracted.

5.7 Test Facility

The test facility is recognized, certified, or accredited by the following organizations:

CNAS-Lab Code: L1910

Centre Testing International Group Co., Ltd. has been assessed and proved to be in compliance with CNAS-CL01 Accreditation Criteria for Testing and Calibration Laboratories (identical to ISO/IEC 17025: 2005 General Requirements) for the Competence of Testing and Calibration Laboratories..

A2LA-Lab Cert. No. 3061.01

Centre Testing International Group Co., Ltd. EMC Laboratory has been accredited by A2LA for technical competence in the field of electrical testing, and proved to be in compliance with ISO/IEC 17025: 2005 General Requirements for the Competence of Testing and Calibration Laboratories and any additional program requirements in the identified field of testing.

FCC-Registration No.: 886427

Centre Testing International Group Co., Ltd. EMC Laboratory has been registered and fully described in a report filed with the FCC (Federal Communications Commission). The acceptance letter from the FCC is maintained in our files. Registration 886427.

IC-Registration No.: 7408A-2

The 3m Alternate Test Site of Centre Testing International Group Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 7408A-2.

IC-Registration No.: 7408B-1

The 10m Alternate Test Site of Centre Testing International Group Co., Ltd. has been registered by Certification and Engineering Bureau of Industry Canada for the performance of radiated measurements with Registration No. 7408B-1.

NEMKO-Aut. No.: ELA503

Centre Testing International Group Co., Ltd. has been assessed the quality assurance system, the testing facilities, qualifications and testing practices of the relevant parts of the organization. The quality assurance system of the Laboratory has been validated against ISO/IEC 17025 or equivalent. The laboratory also fulfils the conditions described in Nemko Document NLA-10.

VCCI

The Radiation 3 &10 meters site of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: R-4096.

Hotline: 400-6788-333 www.cti-cert.com E-mail: info@cti-cert.com Complaint call: 0755-33681700 Complaint E-mail: complaint@cti-cert.com





Main Ports Conducted Interference Measurement of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: C-4563.

Telecommunication Ports Conducted Disturbance Measurement of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: T-2146.

The Radiation 3 meters site of Centre Testing International Group Co., Ltd. has been registered in accordance with the Regulations for Voluntary Control Measures with Registration No.: G-758

5.8 Deviation from Standards

None.

5.9 Abnormalities from Standard Conditions

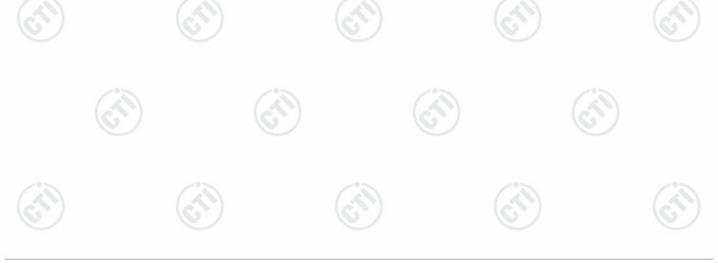
None.

5.10 Other Information Requested by the Customer

None.

5.11 Measurement Uncertainty (95% confidence levels, k=2)

No.	Item	Measurement Uncertainty	
1	Radio Frequency	7.9 x 10 ⁻⁸	
2 Radiated Spurious emission		4.5dB (30MHz-1GHz)	
		4.8dB (1GHz-12.75GHz)	
O Conduction on	Conduction optionism	3.6dB (9kHz to 150kHz)	
3	Conduction emission	3.2dB (150kHz to 30MHz)	
4	Temperature	0.64°C	
5	Humidity	2.8%	
6	DC power voltages	0.025%	











Report No. : EED321002128 **6 Equipment List**

Page 8 of 22

	3M	Semi/full-anech	oic Chamber		
Equipment	Manufacturer	Model No.	Serial Number	Cal. date (mm-dd-yyyy)	Cal. Due date (mm-dd-yyyy)
3M Chamber & Accessory Equipment	TDK	SAC-3		06-05-2016	06-05-2019
TRILOG Broadband Antenna	SCHWARZBECK	VULB9163	9163-484	05-23-2016	05-22-2017
Microwave Preamplifier	Agilent	8449B	3008A02425	02-04-2016	02-03-2017
Horn Antenna	ETS-LINDGREN	3117	00057407	07-20-2015	07-18-2018
Loop Antenna	ETS	6502	00071730	07-30-2015	07-28-2017
Spectrum Analyzer	R&S	FSP40	100416	06-16-2016	06-15-2017
Receiver	R&S	ESCI	100435	06-16-2016	06-15-2017
Multi device Controller	maturo	NCD/070/10711 112		01-12-2016	01-11-2017
LISN	schwarzbeck	NNBM8125	81251547	06-16-2016	06-15-2017
LISN	schwarzbeck	NNBM8125	81251548	06-16-2016	06-15-2017
Signal Generator	Agilent	E4438C	MY45095744	04-01-2016	03-31-2017
Signal Generator	Keysight	E8257D	MY53401106	04-01-2016	03-31-2017
Temperature/ Humidity Indicator	TAYLOR	1451	1905	04-27-2016	04-26-2017
Communication test set	Agilent	E5515C	GB47050534	04-01-2016	03-31-2017
Cable line	Fulai(7M)	SF106	5219/6A	01-12-2016	01-11-2017
Cable line	Fulai(6M)	SF106	5220/6A	01-12-2016	01-11-2017
Cable line	Fulai(3M)	SF106	5216/6A	01-12-2016	01-11-2017
Cable line	Fulai(3M)	SF106	5217/6A	01-12-2016	01-11-2017
Communication test set	R&S	CMW500	152394	04-01-2016	03-31-2017
High-pass filter	Sinoscite	FL3CX03WG18 NM12-0398-002		01-12-2016	01-11-2017
High-pass filter	MICRO- TRONICS	SPA-F-63029-4	(7)	01-12-2016	01-11-2017
band rejection filter	Sinoscite	FL5CX01CA09C L12-0395-001		01-12-2016	01-11-2017
band rejection filter	Sinoscite	FL5CX01CA08C L12-0393-001		01-12-2016	01-11-2017
band rejection filter	Sinoscite	FL5CX02CA04C L12-0396-002		01-12-2016	01-11-2017
band rejection filter	Sinoscite	FL5CX02CA03C L12-0394-001		01-12-2016	01-11-2017
DC Source	LONG WEI	TPR-6420D	0371643	()	













Report No.: EED32I002128 Page 9 of 22

7 Test Results and Measurement Data

7.1 Radiated Emission

Test Requirement: 47 CFR Part 15B **Test Method:** ANSI C63.4

Test site: Measurement Distance: 3m (Semi-Anechoic Chamber)

Receiver setup:

Limit:

Detector	RBW	VBW	Remark
Quasi-peak	120kHz	300kHz	Quasi-peak Value
Peak	1MHz	3MHz	Peak Value
ency	Limit (dBµV/	/m @3m)	Remark
88MHz	40.0		Quasi-peak Value
16MHz	43.5		Quasi-peak Value
60MHz	46.0		Quasi-peak Value
-1GHz	54.0)	Quasi-peak Value
1047	54.0		Average Value
IGHZ	74.0)	Peak Value
	Quasi-peak Peak ency 8MHz 16MHz	Quasi-peak 120kHz Peak 1MHz ency Limit (dBµV, 68MHz 40.0 16MHz 43.5 160MHz 46.0 1GHz 54.0	Quasi-peak 120kHz 300kHz Peak 1MHz 3MHz ency Limit (dBµV/m @3m) 8MHz 40.0 16MHz 43.5 60MHz 46.0 1GHz 54.0 54.0

Test Procedure:

Below 1GHz test procedure as below:

- a. The EUT was placed on the top of a rotating table 0.8 meters above the ground at a 3 meter semi-anechoic camber. The table was rotated 360 degrees to determine the position of the highest radiation.
- b. The EUT was set 3 meters away from the interference-receiving antenna, which was mounted on the top of a variable-height antenna tower.
- c. The antenna height is varied from one meter to four meters above the ground to determine the maximum value of the field strength. Both horizontal and vertical polarizations of the antenna are set to make the measurement.
- d. For each suspected emission, the EUT was arranged to its worst case and then the antenna was tuned to heights from 1 meter to 4 meters and the rota table table was turned from 0 degrees to 360 degrees to find the maximum reading.
- e. The test-receiver system was set to Peak Detect Function and Specified Bandwidth with Maximum Hold Mode.
- f. If the emission level of the EUT in peak mode was 10dB lower than the limit specified, then testing could be stopped and the peak values of the EUT would be reported. Otherwise the emissions that did not have 10dB margin would be retested one by one using peak, quasi-peak or average method as specified and then reported in a data sheet.

Above 1GHz test procedure as below:

- g. Different between above is the test site, change from Semi- Anechoic Chamber to fully Anechoic Chamber (Above 18GHz the distance is 1 meter).
- The radiation measurements are performed in X, Y, Z axis positioning for Transmitting mode, and found the X axis positioning which it is worse case.
- i. Repeat above procedures until all frequencies measured was complete.



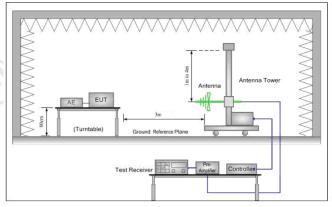






Page 10 of 22

Test Setup:



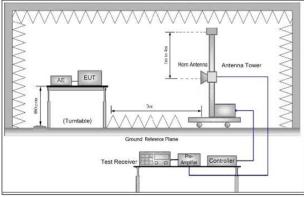


Figure 1. 30MHz to 1GHz

Figure 2. Above 1 GHz

Instruments Used: Refer to section 6 for details

Test Mode: Normal operation mode

Test Results: Pass



























































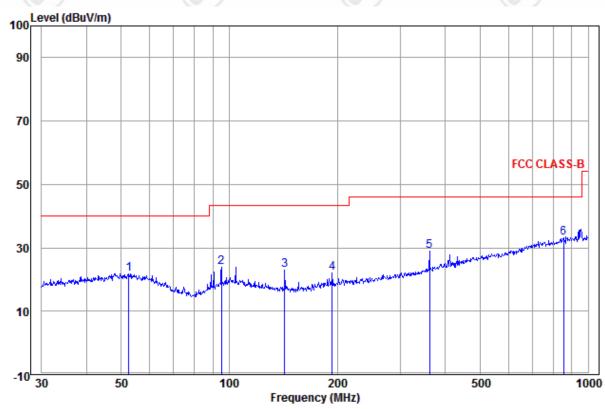




Page 11 of 22

Report No.: EED32I002128

Below 1GHz: Horizontal



		Ant	Cable	Read		Limit	0ver		
	Freq	Factor	Loss	Level	Level	Line	Limit	Pol/Phase	Remark
-	MHz	dB/m	dB	dBuV	dBuV/m	dBuV/m	——dB		
1	52.575	14.74	1.41	5.69	21.84	40.00	-18.16	Horizontal	
2	95.093	12.24	1.58	9.98	23.80	43.50	-19.70	Horizontal	
3	142.824	10.12	1.58	11.33	23.03	43.50	-20.47	Horizontal	
4	193.773	11.39	2.14	8.41	21.94	43.50	-21.56	Horizontal	
5	361.714	15.17	2.73	11.05	28.95	46.00	-17.05	Horizontal	
6 pp	854.025	21.94	4.19	7.02	33.15	46.00	-12.85	Horizontal	































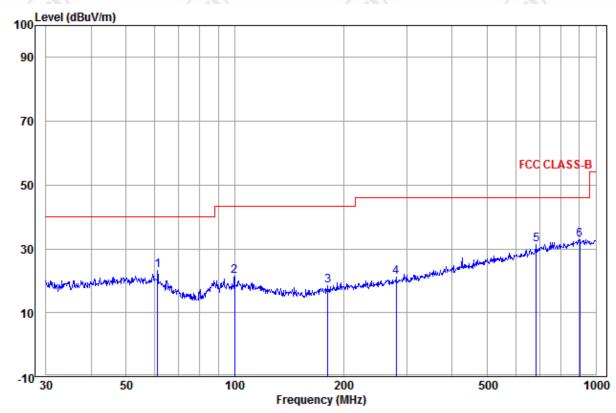






Vertical

Page 12 of 22



		Ant	Cable	Read		Limit	0ver			
	Freq	Factor	Loss	Level	Level	Line	Limit	Pol/Phase	Remark	
_										
	MHz	dB/m	dB	dBuV	dBuV/m	d Bu V/m	dB			
1	61.132	13.39	1.43	8.34	23.16	40.00	-16.84	Vertical		
2	99.878	13.18	1.57	6.69	21.44	43.50	-22.06	Vertical		
3	181.283	10.95	1.99	5.59	18.53	43.50	-24.97	Vertical		
4	280.024	13.08	2.37	5.58	21.03	46.00	-24.97	Vertical		
5	684.745	20.37	3.79	7.11	31.27	46.00	-14.73	Vertical		
6 рр	903.309	22.40	4.34	6.09	32.83	46.00	-13.17	Vertical		





































Page 13 of 22

-23.29

-24.63

Pass

Pass

Report No.: EED32I002128

Above 1GHz Peak value:

Frequency (MHz)	Antenna Factor (dB/m)	Cable Loss (dB)	Preamp Gain (dB)	Read Level (dBµV)	Level (dBµV/m)	Limit (dBµV/m)	Over Limit (dB)	Result	Antenna Polaxis
1119.499	30.03	2.42	35.05	47.94	45.34	74	-28.66	Pass	H
1449.030	30.77	2.78	34.72	46.99	45.82	74	-28.18	Pass	Н
1868.851	31.50	3.14	34.39	46.56	46.81	74	-27.19	Pass	H
3086.435	33.52	5.60	34.51	45.69	50.30	74	-23.70	Pass	Н
3765.580	32.97	5.48	34.58	45.50	49.37	74	-24.63	Pass	Н
4702.434	34.47	5.15	34.38	44.95	50.19	74	-23.81	Pass	Н
1133.628	30.06	2.44	35.04	47.07	44.53	74	-29.47	Pass	V
1449.030	30.77	2.78	34.72	46.99	45.82	74	-28.18	Pass	V
2188.024	32.12	3.76	34.34	46.39	47.93	74	-26.07	Pass	V

3765.580 Remark:

3187.600

33.43

32.97

1) The field strength is calculated by adding the Antenna Factor, Cable Factor & Preamplifier. The basic equation with a sample calculation is as follows:

50.71

49.37

46.22

45.50

Final Test Level =Receiver Reading - Correct Factor

5.58

5.48

Correct Factor = Preamplifier Factor - Antenna Factor - Cable Factor

34.52

34.58

- 2) As shown in this section, for frequencies above 1GHz, the field strength limits are based on Peak limits. However, the peak field strength of any emission shall not exceed the maximum permitted average limits specified above by more than 20 dB under any condition of modulation. So, only the peak values are measured.
- 3) Scan from 30MHz to 5GHz, the above harmonics were the highest point could be found when testing, so only the above harmonics had been displayed. The amplitude of spurious emissions from the radiator which are attenuated more than 20dB below the limit need not be reported.

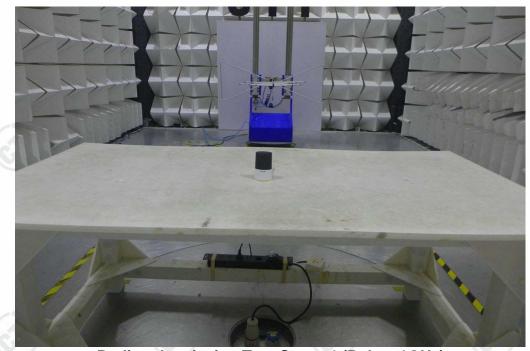




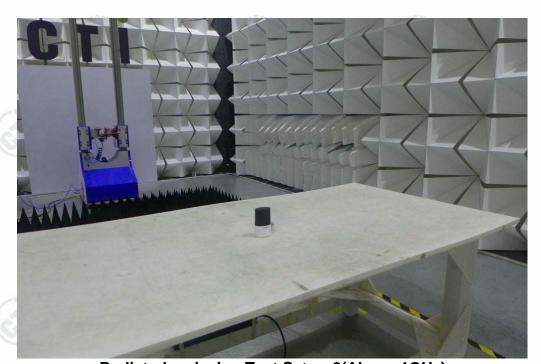


APPENDIX 1 PHOTOGRAPHS OF TEST SETUP

Test Model No.: DB100C



Radiated emission Test Setup-1 (Below 1GHz)



Radiated emission Test Setup-2(Above 1GHz)















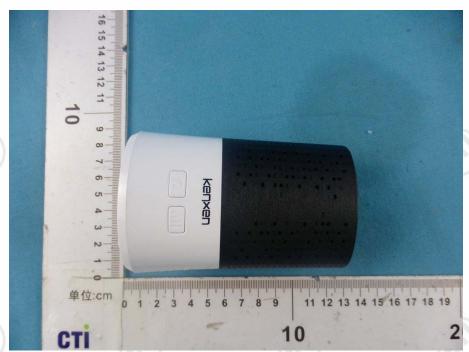




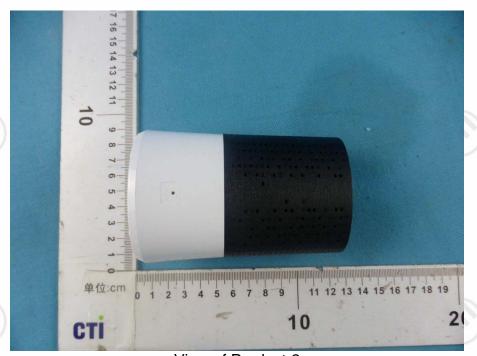
Page 15 of 22 Report No.: EED32I002128

APPENDIX 2 PHOTOGRAPHS OF EUT

Test model No.: DB100C



View of Product-1



View of Product-2















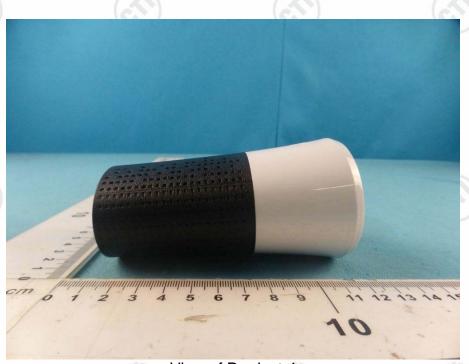




Report No. : EED32I002128 Page 16 of 22



View of Product-3



View of Product-4









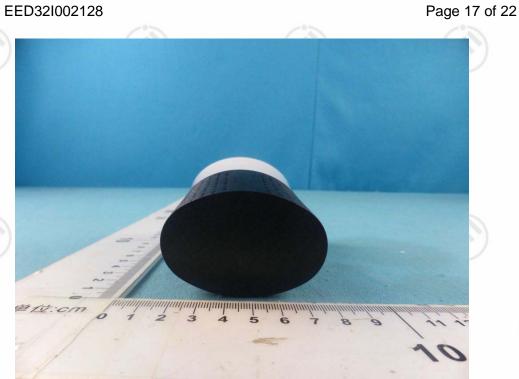












View of Product-5



View of Product-6



















Page 18 of 22

Report No.: EED32I002128





View of Product-8

















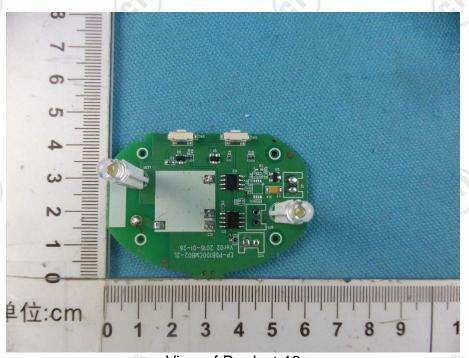


Page 19 of 22

Report No. : EED32I002128



View of Product-9



View of Product-10











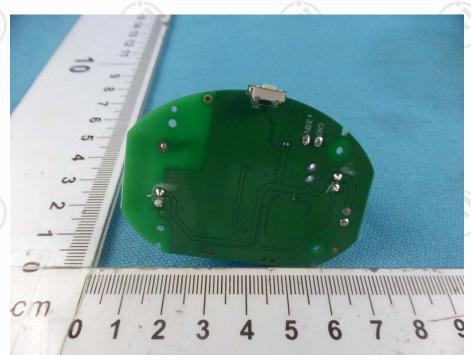




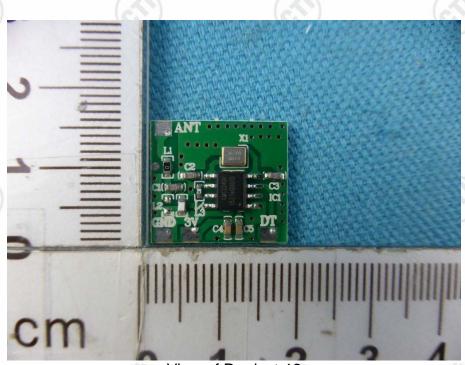


Page 20 of 22

Report No.: EED32I002128



View of Product-11



View of Product-12













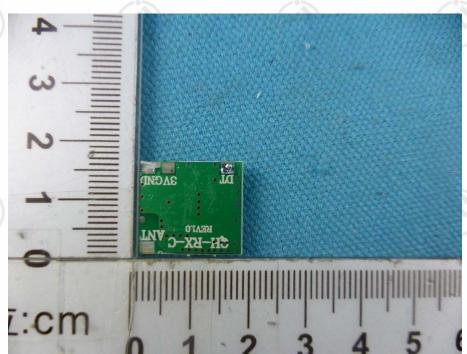






Page 21 of 22

Report No.: EED32I002128



View of Product-13



View of Product-14











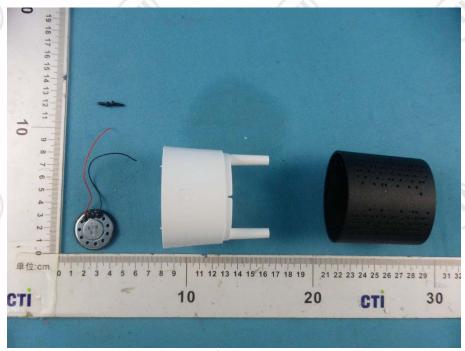












View of Product-15

*** End of Report ***

The test report is effective only with both signature and specialized stamp. The result(s) shown in this report refer only to the sample(s) tested. Without written approval of CTI, this report can't be reproduced except in full.

